## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination NGUYEN ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0139190 A1	07-2003	Steelberg et al.	455/456
*	В	US-6,264,557 B1	07-2001	Schneier et al.	463/29
*	O	US-2002/0169021 A1	11-2002	Urie et al.	463/25
*	D	US-2005/0005127 A1	01-2005	Rowe et al.	713/182
*	Е	US-6,003,014	12-1999	Lee et al.	705/13
*	F	US-5,153,918	10-1992	Tuai, Gregory	713/182
*	G	US-2003/0006931 A1	01-2003	Mages, Ken	342/357.06
*	Ι	US-6,508,709 B1	01-2003	Karmarkar, Jayant S.	463/42
*	-	US-6,104,815	08-2000	Alcorn et al.	380/251
*	7	US-4,575,622	03-1986	Pellegrini, Frank J.	463/25
*	К	US-5,287,269	02-1994	Dorrough et al.	705/17
*	L	US-6,190,257 B1	02-2001	Takeda et al.	463/29
*	М	US-4,467,424	08-1984	Hedges et al.	463/26

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P		•			
	Q					
	R					
	S	• -				
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.